# Multi-Element Array Series

### Planar Diffused Silicon Photodiodes

Multichannel array photodetectors consist of a number of single element photodiodes laid adjacent to each other forming a one-dimensional sensing area on a common cathode substrate. They can perform simultaneous measurements of a moving beam or beams of many wavelengths. They feature low electrical cross talk and super high uniformity between adjacent elements allowing very high precision measurements. Arrays offer a low cost alternative when a large number of detectors are required. The detectors are optimized for either UV, visible or near IR range.

They can be either operated in photoconductive mode (reverse biased) to decrease the response time, or in photovoltaic mode (unbiased) for low drift applications. A2V-16 can be coupled to any scintillator crystal for measuring high-energy photons in the X-ray and g-ray region of electromagnetic spectrum. In addition, they have been mechanically designed, so that several of them can be mounted end to end to each other in applications where more than 16 elements are needed.

Figure 11 in the "Photodiode Characteristics" section of this catalog provides a detailed circuit example for the arrays.



#### APPLICATIONS

- Level Meters
- Optical Spectroscopy
- Medical Equipment
- High Speed Photometry
- Computed Tomography Scanners
- Position Sensors

### FEATURES

- Common Substrate Array
- Ultra Low Cross Talk
- UV Enhanced (A5V-35UV)
- Low Dark Current
- Low Capacitance
- Solderable





### Typical Spectral Response



#### Typical Electro-Optical Specifications at T<sub>A</sub>=23°C

Model Number	Number of Elements	Active Area Per Element		(E	Responsivity (A/W)	Shunt Resistance (MΩ)	Dark Curre (pF)	Dark Current (pF)		ince	NEP (W / √Hz)		Temp. Range (°C)		
		Area (mm²)	insions (mr	Pitch (m	970nm	-10 mV	-10 \	/ 01	,	-10 V	0 V 970nm	-10 V 970nm	rating	rage	Package Style ¶
			Dime (n		typ.	typ.	typ.		typ.		min.	typ.	Ope	Sto	
Photoconductive Arrays															
A5C-35	35	2.0	4 30 × 0.6		0.65		0.05			12		62015			E4 / 40 pip DID
A5C-38	38	3.9	4.39 X 0.8	9 0.99	0.65		0.05			12		0.2 e-15			54 / 40 pin DIP
Photovoltaic Arrays															
A2V-16	16	1.92	1.57 x 1.2	2 1.59	0.60	1000		170			4.8 e-15		+85	125	53 / PCB
A5V-35	35	3.0	4 39 × 0.8		0.60	1000		34(			480-15		2 C	+ 2	54 / 40 pip DIR
A5V-38	38	3.9	4.39 X 0.0	0.99	0.00	1000		540			4.8 6-13	m i	-40	54 / 40 pin DIP	
A2V-76	76	1.8	6.45 x 0.2	.8 0.31	0.50	500		160			8.2 e-15				52 / Ceramic
UV Enhai	nced A	rray	(All Spe	cificatio	ons @ λ =25	54 nm, V <sub>BI</sub>	<sub>AS</sub> = -1	0V)							
A5V-35UV	35	3.9	4.39 x 0.8	0.99	0.06**	500		340			6.8 e-14				54 / 40 pin DIP
				P.						_	0				
Model Number	Number of Elements	Element Size Active per Element		Active Ar per Eleme	ea Pitch	Respons (A/W	onsivity A/W) Ott		pen Circuit age/Element (mV)		Shunt Ca Resistance (MΩ)		acitance (pF)		
		mm (inches)		(mm²)	mm	970ni	m	10 mW/cm2 2850 °K			-10 mV		0 V		
				(incries	(incres) (incres)		typ.		typ.		typ.	t	typ.		

# Monolithic Solderable Chip Arrays (Typical Electro-Optical Specifications at T<sub>A</sub>=23°C)

			. ,	、 / I	•	•	A /		
A4V-2	2								
A4V-4	4	1.52 x 2.79 (0.06 x 0.110)	4.24 (0.007)	1.90 (0.075)	0.6	500	1000	500	
A4V-6	6								
A4V-8	8								
A4V-10	10								
A4V-12	12								

The chips are equipped with 2" long bare tinned leads soldered to all anodes and the common cathode.

'V' suffix indicates the device is optimized for 'photovoltaic' operation.
'C' suffix indicates the device is optimized for 'photoconductive' operation.
'For mechanical drawings please refer to pages 58 thru 69.
\* Non-Condensing temperature and Storage Range, Non-Condensing Environment.

\*\*  $\lambda = 254 \text{ nm}$ 

